## AN2982 <br> Application note

## $1 \times 54$ W T5 fluorescent lamp ballast in wide input voltage range using the L6585DE - STEVAL-ILB005V2

## Introduction

This application note describes the STEVAL-ILB005V2 demonstration board equipped with the L6585DE lighting controller, STD7NM50N MOSFETs and an STTH1L06 Shottky diode able to drive a 54 W linear T 5 fluorescent lamp in a wide input voltage range (88-277 Vac). The design steps, schematic and board performance are also given.

The L6585DE lighting controller embeds both the PFC stage and ballast stage suitable for driving all kinds of lamps (T8, T5, T4, CFLn,...) and all kinds of topologies having an input power greater than 25 W .

New T5 lamps are characterized by very high luminous efficiency and compactness. To optimize their performance, high accuracy in both preheating of the cathodes and steadystate parameters is required. The minimum performance of T5 ballasts together with their minimum safety requirements are summarized in international norms, especially IEC61347-2-3, IEC60929, and IEC60081.

The demand for these lamps is rapidly growing and the L6585DE is able to control electronic ballasts meeting all performance specifications and reliability with low component count and a small PCB.

The STEVAL-ILB005V2 has been developed to drive a 54 W T5-HO lamp.
Figure 1. STEVAL-ILB005V2 demonstration board


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## 1 <br> Designing the application

The STEVAL-ILB005V2 design follows the AN2870 design guidelines. In this section the design specifications and the equations used are given.

### 1.1 Design requirements

Table 1. Summary of design requirements

| Description | Values |
| :---: | :---: |
| Input voltage | 88 to $277 \mathrm{Vac}(110$ to $230 \mathrm{Vac} \pm 20 \%)$ |
| Mains frequency | $50 \mathrm{~Hz}-60 \mathrm{~Hz}$ |
| PF | $>0.975$ |
| Current THD | $<10 \%$ |
| Lamp type | T5 -54 W HO (l lamp $\left.=460 \mathrm{mArms} ; \mathrm{V}_{\text {lamp }}=117 \mathrm{Vrms}\right)$ |
| Max output voltage | 900 Vrms |
| Lamp connection | Current preheated, $\mathrm{C}_{\text {block }}$ to ground topology |
| Efficiency | $90 \%$ |

Figure 2. Typical application schematic


### 1.2 PFC design

### 1.2.1 Output voltage and dynamic OVP

The maximum input voltage is equal to:

## Equation 1

$$
\mathrm{V}_{\mathrm{in}, \max }=277 \mathrm{~V} \cdot \sqrt{2}=391.7 \mathrm{~V}
$$

An output voltage equal to $\mathrm{V}_{\text {out }}=420 \mathrm{~V}$ is chosen for better PFC performance.
Choosing $R_{\text {invh }}=3 \times 2.2 \mathrm{M} \Omega$, the output voltage is equal to:

## Equation 2

$$
\mathrm{V}_{\text {out }}=2.52 \mathrm{~V} \cdot\left(1+\frac{\mathrm{R}_{\text {invh }}}{\mathrm{R}_{\text {invl }}}\right) \rightarrow \mathrm{R}_{\text {invl }}=\frac{\mathrm{R}_{\text {invh }}}{\left(\frac{\mathrm{V}_{\text {out }}}{2.52 \mathrm{~V}}-1\right)}=39839 \Omega \rightarrow \mathrm{R}_{\text {invi }}=39.7 \mathrm{k} \Omega
$$

The ripple superimposed on $\mathrm{V}_{\text {out }}$ is chosen equal to $5 \%$. Then, the maximum instantaneous output voltage is equal to 441 V and, therefore, the OVP level must be comprised between 450 V and 500 V.
$-\quad V_{\text {OVP }}=480 \mathrm{~V}$ is chosen and the CTR pin voltage divider is dimensioned accordingly

- $\quad \mathrm{R}_{\mathrm{ctrh}}=3 \times 825 \mathrm{k} \Omega$


## Equation 3

$$
\mathrm{V}_{\mathrm{OVP}}=3.4 \mathrm{~V} \cdot\left(1+\frac{\mathrm{R}_{\mathrm{ctrh}}}{\mathrm{R}_{\mathrm{ctrl}}}\right) \rightarrow \mathrm{R}_{\mathrm{ctrl}}=\frac{\mathrm{R}_{\mathrm{ctrh}}}{\left(\frac{\mathrm{~V}_{\mathrm{OUT}, \mathrm{MAX}}}{3.4 \mathrm{~V}}-1\right)}=17656 \Omega \rightarrow \mathrm{R}_{\mathrm{invi}}=18 \mathrm{k} \Omega
$$

### 1.2.2 Boost choke design

The minimum PFC frequency is chosen equal to $f_{\text {PFC, min }}>15 \mathrm{kHz}$. The maximum inductance value is equal to:

## Equation 4

$$
f_{P F C, \text { min }}=\frac{V_{\text {in }}^{2}}{2 \cdot P_{\text {in }} \cdot L} \cdot\left(1-\frac{\sqrt{2} \cdot V_{\text {in }}}{V_{\text {out }}}\right) \rightarrow L \leq \frac{V_{\text {in }}^{2}}{2 \cdot P_{\text {in }} \cdot f_{P F C, \text { min }}} \cdot\left(1-\frac{\sqrt{2} \cdot V_{\text {in }}}{V_{\text {out }}}\right)=2.6 \mathrm{mH}
$$

$\mathrm{L}_{\mathrm{pfc}}=1.5 \mathrm{mH}$ is selected. The following graph depicts the frequencies that are obtained along the mains period for various input voltages.

Figure 3. PFC MOSFET frequencies along mains half period ( $f_{\text {mains }}=50 \mathrm{~Hz}$ ) for various input voltages


The maximum choke current is equal to:

## Equation 5

$$
\mathrm{L}_{\mathrm{L}, \max }=2 \cdot \sqrt{2} \cdot \frac{\mathrm{P}_{\mathrm{in}}}{V_{\mathrm{in}, \text { min }}}=1.93 \mathrm{~A}
$$

A saturation current higher than $\mathrm{I}_{\mathrm{L}, \text { sat }}=2.2 \mathrm{~A}$ is used in order to take into account the tolerance of this parameter.
The RMS current flowing into the choke is equal to:

## Equation 6

$$
\mathrm{I}_{\mathrm{L}, \text { RMs }}=\frac{2}{\sqrt{3}} \frac{\mathrm{P}_{\text {in }}}{V_{\mathrm{in}, \text { min }}}=787 \mathrm{~mA}
$$

The choke form factor is an EF25 core ( $\mathrm{A}_{\mathrm{e}}=52 \mathrm{~mm}^{2}, \mathrm{I}_{\mathrm{e}}=58 \mathrm{~mm}$, material N87 or equivalent having $\mathrm{B}_{\text {max }}<320 \mathrm{mT}$ ).
Its design parameters are as follows:

## Equation 7

$$
\left.\begin{array}{l}
N=\frac{I_{\max } L}{B_{\max } A_{e}}=174 \text { turns } \\
A_{L}=\frac{L}{N^{2}}=49.5 \mathrm{nH} / \text { turns }^{2}
\end{array}\right\} \rightarrow I_{\text {gap }}=2 \times \frac{\mu_{0} N^{2} A_{e}}{L}=2.63 \mathrm{~mm}
$$

The maximum power dissipation of the core should be less than 2.5 W in the worst condition.

A multi-conductor wire is used in order to reduce the equivalent resistance at high frequency.

When the maximum RMS current is obtained, the minimum frequency is detected and the RHF of the choke must be less than:

## Equation 8

$$
\mathrm{R}_{\mathrm{HF}, \max }=\frac{\mathrm{P}_{\mathrm{L}, \Omega}}{\mathrm{I}_{\mathrm{L}, \mathrm{RMS}}^{2}}=4 \Omega
$$

Using a $13 \times 0.1 \mathrm{~mm}^{2}$ wire, $3.5 \Omega$ is obtained.
The core losses, at minimum input voltage, are estimated below 0.35 W , therefore the total losses are lower than 2.5 W as expected. The higher the input voltage is, the lower the power dissipation (e.g. at 220 Vac the estimated total power losses are lower than 1.8 W ).

The transformer ratio can be calculated as:

## Equation 9

$$
\mathrm{V}_{\mathrm{aux}, \mathrm{zcd}}=\left(\mathrm{V}_{\text {out }}-\sqrt{2} \cdot \mathrm{~V}_{\text {in }}\right)>\mathrm{m} \cdot 1.4 \mathrm{~V} \rightarrow \mathrm{~m}<14.18 \rightarrow \mathrm{~m}=6 \rightarrow \mathrm{~N}_{\mathrm{sec}}=29 \mathrm{turns}
$$

Considering a maximum ZCD current equal to 1 mA , the limiting resistor is:

## Equation 10

$$
\mathrm{R}_{\mathrm{zcd}}=\frac{\sqrt{2} \cdot \mathrm{~V}_{\mathrm{in}, \max }}{\mathrm{~m} \cdot \mathrm{I}_{\mathrm{zcD}}} \rightarrow \mathrm{R}_{\mathrm{zcd}}>65.3 \mathrm{k} \Omega \rightarrow \mathrm{R}_{\mathrm{zcd}}=75 \mathrm{k} \Omega
$$

### 1.2.3 MOSFET selection

The PFC MOSFET must have a $\mathrm{V}_{\mathrm{bdss}}=500 \mathrm{~V}$ and a peak drain current greater than $\mathrm{I}_{\mathrm{d}, \max }=2.2 \mathrm{~A}$.
The maximum allowed MOSFET dissipation is equal to $P_{M O S, \max }=1 \mathrm{~W}$ in all conditions.
The total power dissipation is composed of:

- Conduction losses, dominant at low input voltage:


## Equation 11

$$
P_{\mathrm{COND}}=\mathrm{R}_{\mathrm{ds}, \mathrm{on}} \cdot I_{\mathrm{MOS}, \mathrm{RMS}}{ }^{2}=R_{\mathrm{ds}, \mathrm{on}} \cdot 8\left(\frac{\mathrm{P}_{\mathrm{in}}}{\mathrm{~V}_{\mathrm{in}, \mathrm{rms}}}\right)^{2}\left[\frac{1}{6}-\frac{4 \sqrt{2}}{9 \pi} \frac{\mathrm{~V}_{\mathrm{in}, \mathrm{rms}}}{\mathrm{~V}_{\mathrm{out}}}\right]=R_{\mathrm{ds}, \text { on }} \cdot 0.5278 \mathrm{~A}^{2}
$$

## Equation 12

$$
\mathrm{R}_{\mathrm{DS}(\text { on })}(\max )<\frac{\mathrm{P}_{\mathrm{COND}, \max }}{0.5278 \mathrm{~A}^{2}}
$$

- Switching losses, directly proportional to the average switching frequency:


## Equation 13

$$
\left\langle\mathrm{f}_{\mathrm{SW}}\right\rangle=\frac{\mathrm{V}_{\mathrm{in}, \mathrm{RMS}}^{2}}{2 \cdot \mathrm{P}_{\mathrm{in}} \cdot \mathrm{~L}}\left(1-\frac{2 \sqrt{2}}{\pi} \cdot \frac{\mathrm{~V}_{\mathrm{IN}, \mathrm{RMS}}}{\mathrm{~V}_{\mathrm{out}}}\right)
$$

## Equation 14

$$
P_{\text {cross }}=t_{f}\left\langle f_{\text {sw }}\right\rangle V_{\text {out }} \frac{P_{\text {in }}}{V_{\text {in }, \text { rms }}}=\frac{t_{f}\left\langle f_{\text {sw }}\right\rangle}{V_{\text {in,rms }}} \cdot 25200
$$

- Capacitive losses, present only when $\mathrm{V}_{\text {in }}>\mathrm{V}_{\text {out }} / 2$ and have their maximum at $\mathrm{V}_{\text {in, max }}$ The maximum time when the input voltage is greater than $\mathrm{V}_{\text {out }} / 2$ can be calculated as follows:


## Equation 15

$$
\begin{aligned}
& t_{1}=\frac{\arcsin \left(\frac{v_{\text {out }}}{2 \cdot \sqrt{2} \cdot v_{\text {in,ms }}}\right)}{2 \pi f_{\text {mains }}} \rightarrow 1.8 \mathrm{~ms} \\
& t_{2}=\frac{1}{2 f_{\text {mains }}}-t_{1} \rightarrow 8.2 \mathrm{~ms}
\end{aligned}
$$

Within this interval the capacitive losses are:

## Equation 16

$$
P_{\text {cap }}=\left\langle\mathrm{f}_{\text {sw }}\right\rangle\left(3.3 \mathrm{C}_{\text {oss }}\left\langle\mathrm{V}_{\text {Drain }}\right\rangle^{\frac{3}{2}}+\frac{1}{2}\left(\mathrm{C}_{\text {rss }}+\mathrm{C}_{\text {oss }}+\mathrm{C}_{\text {ext }}\right)\left\langle\mathrm{V}_{\text {Drain }}\right\rangle^{2}\right)
$$

where $<\mathrm{f}_{\mathrm{sw}}>=173 \mathrm{kHz}$ and:

## Equation 17

$$
\left\langle\mathrm{V}_{\text {Drain }}\right\rangle=\sqrt{2 \mathrm{f}_{\text {mains }} \int_{\mathrm{t}_{1}}^{\mathrm{t}_{2}}\left[2 \sqrt{2} \cdot \mathrm{~V}_{\text {in, }, \text { ms }} \sin (\omega \mathrm{t})-\mathrm{V}_{\text {out }}\right]^{2} \mathrm{dt}}=209.7 \mathrm{~V}
$$

Using Equation 11 to 17 with the constraint $P_{\text {tot }}<1 \mathrm{~W}$, the following parameters are found:

- $\quad R_{D S(o n)}<1.4 \Omega\left(P_{\text {cond }}\right.$ at $\left.88 \mathrm{~V}<0.75 \mathrm{~W}\right)$
- $\mathrm{t}_{\mathrm{f}}<10 \mathrm{~ns}\left(\mathrm{P}_{\text {cross }}\right.$ at $88 \mathrm{~V}<0.10 \mathrm{~W}$ )
- $\quad C_{\text {oss }}<110 \mathrm{pF}$ (considering $\mathrm{C}_{\text {ext }}$ and $\mathrm{C}_{\text {rss }}$ equal respectively 68 pF and 4 pF )

The following ST MOSFETs meet these constraints:

- STD5NK50Z
- STD6NK50Z
- STD7NM50N

The STD7NM50N has $R_{\text {DS(on) }}=1.12 \Omega$ (at $100^{\circ} \mathrm{C}$ ), $\mathrm{t}_{\mathrm{f}}=9 \mathrm{~ns}$ and $\mathrm{C}_{\text {oss }}=67 \mathrm{pF}$ and therefore is considered suitable for this design. The total power dissipation is shown in Figure 4.

Figure 4. Summary of PFC MOSFET power losses


### 1.2.4 Boost diode selection

Both the boost diode maximum RMS current and the RMS current are equal to:

## Equation 18

$$
\mathrm{I}_{\mathrm{d}, \mathrm{~ms}}=\frac{4}{3} \frac{\sqrt{2 \sqrt{2}}}{\pi} \frac{\mathrm{P}_{\mathrm{in}}}{\sqrt{\mathrm{~V}_{\mathrm{OUT}} \mathrm{~V}_{\mathrm{in}, \mathrm{~ms}}}}=222 \mathrm{~mA}
$$

Their average current is equal to:

## Equation 19

$$
\frac{P_{\text {out }}}{V_{\text {out }}}=142 \mathrm{~mA}
$$

The STTH1L06 Shottky diode is selected, having $\mathrm{V}_{\text {rrm }}=600 \mathrm{~V}$ and an average forward current $\mathrm{I}_{\mathrm{f}(\mathrm{AV})}=1 \mathrm{~A}$. Total power dissipation is equal to:

## Equation 20

$$
P_{D}=0.89 \cdot 0.142+0.165 \cdot 0.222^{2}=134.5 \mathrm{~mW}
$$

### 1.2.5 Bulk capacitor selection

The ripple superimposed on the output voltage is equal to $\pm 20 \mathrm{~V}$ :

## Equation 21

$$
\begin{aligned}
& \Delta \mathrm{V}_{\text {out }}=20 \mathrm{~V}=\frac{\mathrm{P}_{\text {out }}}{4 \pi \cdot \mathrm{f}_{\text {mains }} \cdot \mathrm{V}_{\text {out }} \cdot \mathrm{C}_{\text {out }}}+\mathrm{ESR}_{@ \mathrm{f}_{\mathrm{PFC}, \text { min }}} \cdot \mathrm{I}_{\mathrm{C}_{\text {out }}, R M S}= \\
& =\frac{2.0463 \times 10^{-4}}{\mathrm{C}_{\text {out }}}+\mathrm{ESR} \cdot 373 \mathrm{~mA}
\end{aligned}
$$

The RMS value of the bulk capacitor current is:

## Equation 22

$$
\mathrm{I}_{\mathrm{C}_{\text {out }}, R M S}=\sqrt{\frac{32 \cdot \sqrt{2}}{9 \pi} \cdot \frac{\mathrm{P}_{\text {in }}^{2}}{\mathrm{~V}_{\text {in,rms }} \cdot \mathrm{V}_{\text {out }}}-\left(\frac{\mathrm{P}_{\text {out }}}{\mathrm{V}_{\text {out }}}\right)^{2}}=373 \mathrm{~mA}
$$

Considering the first term of Equation 21 as dominant, $C_{\text {out }}>10.2 \mu \mathrm{~F}$, and then $\mathrm{C}_{\text {out }}=22 \mu \mathrm{~F}$ is selected.
The voltage rating of the capacitor is equal to $\mathrm{V}_{\text {Cout }}=450 \mathrm{~V}$ and the temperature class is $\mathrm{T}_{\text {Cout }}=105^{\circ} \mathrm{C}$. With this value the typical ESR is around $2 \Omega$, adding only 740 mV to the total ripple.

### 1.2.6 Multiplier biasing and selection of PFC current sense resistor

The peak values of the input voltage are between 124.4 V and 391.7 V . The ratio between these two values is equal to 3.15 . The MULT pin is biased to 1 V when input voltage is equal to 124.4 V . If $\mathrm{R}_{\text {multh }}=3 \times 680 \mathrm{k} \Omega$ :

## Equation 23

$$
\mathrm{kp}=\frac{\mathrm{V}_{\mathrm{MULT}, 1}}{\left.\mathrm{~V}_{\mathrm{in}, \text { min }}\right|_{\mathrm{pk}}}=0.00804 \rightarrow \mathrm{R}_{\text {multl }}=\frac{\mathrm{kp}}{1-\mathrm{kp}} R_{\text {multh }}=16.53 \mathrm{k} \Omega \rightarrow \mathrm{R}_{\text {multh }}=16.2 \mathrm{k} \Omega
$$

Figure 5. Multiplier bias points

with $\mathrm{V}_{\mathrm{CS}, 1}=0.75 \mathrm{~V}$ :

## Equation 24

$$
R_{\mathrm{pfccs}}=\frac{\mathrm{V}_{\mathrm{CS}, 1}}{\mathrm{I}_{\mathrm{L}, \text { max }}}=\frac{\mathrm{V}_{\mathrm{CS}, 1} \cdot \mathrm{~V}_{\mathrm{in}, \text { min }}}{2 \cdot \sqrt{2} \cdot \mathrm{P}_{\mathrm{in}}}=0.364 \Omega \rightarrow \mathrm{R}_{\mathrm{pfccs}}=0.33 \Omega
$$

$A C_{\text {mult }}=1 \mathrm{nF}$ capacitor is used in parallel with $\mathrm{R}_{\text {multt }}$ for HF noise filtering.

### 1.2.7 Error amplifier compensation

Figure 6. Control loop block diagram


## Equation 25

$$
G(s)=\frac{1}{4} \frac{\mathrm{k}_{\mathrm{M}} \mathrm{k}_{\mathrm{p}} \mathrm{~V}_{\text {in,rms }}{ }^{2}}{\mathrm{~V}_{\text {out }}} \frac{R_{\text {out }}}{R_{\text {pfcs }}} \frac{1}{1+\mathrm{s} \frac{R_{\text {out }} C_{\text {out }}}{2}}=0.020308 \cdot V_{\text {in }, \text { rms }}{ }^{2} \cdot \frac{1}{1+0.029623 \mathrm{~s}}
$$

where:

- $\quad \mathrm{k}_{\mathrm{M}}=$ multiplier factor $=0.52$
- $\quad k_{p}=$ mult pin divider $=0.007879$
- $\quad R_{\text {out }}=$ equivalent output resistor $=2.693 \mathrm{k} \Omega$
- $\quad C_{\text {out }}=22 \mu \mathrm{~F}$

Using the simplest compensation network (a capacitor placed between the INV and COMP pin) whose transfer function is equal to:

## Equation 26

$$
\mathrm{G}_{\text {comp }}(\mathrm{s})=\frac{1}{s C_{\text {comp }} \mathrm{R}_{\text {invh }}}=\frac{1}{\mathrm{sC} \mathrm{C}_{\text {comp }} \cdot 6.6 \mathrm{M} \Omega}
$$

and setting an open loop gain less than 0.001 when frequency is equal to twice the mains frequency, it is possible to calculate the minimum capacitance needed.

## Equation 27

$$
\left.\mathrm{G}_{\text {loop }}(\mathrm{s})\left|=\mathrm{G}(\mathrm{~s}) \cdot \mathrm{G}_{\text {comp }}(\mathrm{s})\right|=\left|\left(\frac{1}{\mathrm{sC} \mathrm{C}_{\text {comp }} 6.6 \mathrm{M} \Omega}\right) \cdot 0.020308 \cdot \mathrm{~V}_{\text {in,rms }}{ }^{2} \cdot \frac{1}{1+0.029623 \mathrm{~s}}\right|_{\mathrm{s}=2 \pi 100 \mathrm{~Hz}} \right\rvert\,=0.001
$$

$\mathrm{A} \mathrm{C}_{\text {comp }}=1 \mu \mathrm{~F}$ ceramic capacitor could be a good trade-off between performance and cost, but better performance can be obtained using a more complicated structure in order to obtain a phase margin equal to $45^{\circ}$.

Figure 7. Bode plot with simple compensation network: IGloopl $_{\text {MAX }}<35 \mathrm{~dB}$


For example, an RC-series network is connected between the INV and COMP pin. The obtained $\mathrm{G}_{\text {loop }}(\mathrm{s})$ can be written as:

## Equation 28

$$
\mathrm{G}_{\text {loop }}(\mathrm{s})\left|=\mathrm{G}(\mathrm{~s}) \cdot \mathrm{G}_{\text {comp }}(\mathrm{s})\right|=\left|\left(\frac{1+\mathrm{sC}_{\text {comp }} \mathrm{R}_{\text {comp }}}{\mathrm{sC} \mathrm{c}_{\text {comp }} 6.6 \mathrm{M} \Omega}\right) \cdot 0.020308 \cdot \mathrm{~V}_{\text {in,rms }}{ }^{2} \cdot \frac{1}{1+0.029623 \mathrm{~s}}\right|
$$

A phase margin equal to $45^{\circ}$ is obtained at $\operatorname{Vin}=277 \mathrm{Vac}$ using $\mathrm{C}_{\text {comp }}=1.5 \mu \mathrm{~F}$ and $R_{\text {comp }}=39 \mathrm{k} \Omega$. At minimum input voltage the phase margin is equal to $85^{\circ}$.
Higher values of $\mathrm{C}_{\text {comp }}$ or a lower value of $\mathrm{C}_{\text {out }}$ can also improve the PFC performance.
Figure 8. Bode plot with enhanced compensation network: $\left.\mathrm{IG}_{\text {loop }}\right|_{\mathrm{MAX}}<35 \mathrm{~dB}$ and $\Phi$ margin $>45^{\circ}$


### 1.2.8 Input rectifier

A 2KBP06M bridge rectifier is able to sustain 600 V in reverse condition and 2 A of forward current. Its maximum power dissipation is equal to:

Equation 29

$$
P_{B}=2 \sqrt{2} \frac{P_{\text {in }}}{V_{\text {in,rms }(\min )}} V_{F}=1.73 \mathrm{~W}
$$

### 1.2.9 Input capacitor

Let $r=10 \%$ be the maximum allowed ratio between the high-frequency ripple amplitude seen at the input of the PFC stage and the mean value of the input current:

## Equation 30

$$
\mathrm{C}_{\mathrm{in}, \min }=\frac{\mathrm{P}_{\mathrm{in}}}{2 \pi \cdot \mathrm{r} \cdot\left\langle\mathrm{f}_{\mathrm{sw}}\right\rangle_{\min } \cdot \mathrm{V}_{\mathrm{in}, \mathrm{RMS}(\min )}^{2}}=401.87 \mathrm{nF} \rightarrow \mathrm{C}_{\mathrm{in}}=470 \mathrm{nF}
$$

### 1.2.10 Input circuitry

The input circuitry is composed of:

- A fuse: avoids damage due to ballast breaking or excessive current from the mains
- An NTC: limits the inrush current which avoids blowing the fuse and reduces the effects of a burst from the mains. This component reduces its resistance at a higher temperature. A $5 \Omega$ NTC (at $25^{\circ} \mathrm{C}$ ) is used
- A varistor (not present): absorbs the energy associated with a mains surge avoiding that $\mathrm{V}_{\text {out }}$ increases over the rated voltage of the components $\left(\mathrm{C}_{\text {out }}\right.$, MOSFETs, IC,...)
- An EMI filter: an LC network able to reduce the HF noise coming from the application and traveling through the mains. This filter has to filter both the common mode component of the noise (which can be measured between the AC input and the EARTH) and the differential mode component of the noise (which can be measured between the two AC inputs)

The first component (the fuse) is filtered by a CM filter (a current transformer that forces the AC input currents to travel in the opposite way) and two 1 nF capacitor placed between each AC input and EARTH. The second component (the NTC) is filtered by two capacitors placed across the AC inputs and by the leakage inductance of the CM filter. In fact by using a CM transformer having a high leakage inductance, a differential filtering can be obtained. The differential capacitors are equal to $C_{X}=100 \mathrm{nF}$, while the CM capacitors are equal to $\mathrm{C}_{Y}=1 \mathrm{nF}$. The CM transformer, $\mathrm{T}_{\mathrm{CM}}$, is a B82733F series transformer from EPCOS.

Figure 9. Complete EMI filter (differential mode inductors are not present in this design)


## 2 Ballast stage design

Figure 10. Resonant inverter simplified schematic


### 2.1 Resonant network and operating point design

Equivalent voltage applied to the resonant network:
Equation 31

$$
\mathrm{V}_{\mathrm{bal}, \mathrm{pk}}=\frac{2}{\pi} \mathrm{~V}_{\text {out }}=267.38 \mathrm{Vpk}
$$

L and C are chosen in order to fit the following constraints:

- Preheating voltage has to be less than 240 Vac $=339.4$ Vpk
- Maximum striking voltage is equal to 700 Vac
- Nominal lamp voltage = 117 Vac
- Nominal lamp current $=0.46 \mathrm{~A}$

Selecting a common value equal to $\mathrm{L}_{\mathrm{res}}=1.35 \mathrm{mH}$ and $\mathrm{C}_{\mathrm{res}}=4.7 \mathrm{nF}$, the following parameters are obtained:

Equation 32

$$
\left\{\begin{array}{l}
\mathrm{f}_{0}=\frac{1}{2 \pi \sqrt{\mathrm{~L}_{\text {res }} \mathrm{C}_{\text {res }}}}=64387 \mathrm{~Hz} \\
\mathrm{Z}_{0}=\sqrt{\frac{\mathrm{L}_{\text {res }}}{\mathrm{C}_{\text {res }}}}=526 \Omega \\
\mathrm{Q}=\frac{\mathrm{R}_{\text {lamp }}}{\mathrm{Z}_{0}}=\frac{V_{\text {run }}}{\mathrm{I}_{\text {run }} Z_{0}}=0.4836
\end{array}\right.
$$

The run and preheating frequencies are calculated using the values calculated in Equation 33:

Equation 33

$$
\begin{aligned}
& f_{\text {run }}=f_{0} \sqrt{\frac{\left(2-\frac{1}{Q^{2}}\right)+\sqrt{\left(2-\frac{1}{Q^{2}}\right)^{2}-4+\left(\frac{4 V_{\text {out }}}{\pi \cdot Z_{0} \cdot Q \cdot \sqrt{2} I_{\text {run }}}\right)^{2}}}{2}}=48.5 \mathrm{kHz} \\
& \mathrm{f}_{\text {pre }}=\mathrm{f}_{0} \sqrt{1+\frac{2 \mathrm{~V}_{\text {out }}}{\pi \mathrm{V}_{\text {pre }}}}>86 \mathrm{kHz} \rightarrow \mathrm{f}_{\text {pre }}=100 \mathrm{kHz} \\
& \mathrm{f}_{\mathrm{ign}}=\mathrm{f}_{0} \sqrt{1+\frac{2 \mathrm{~V}_{\text {out }}}{\pi \cdot \sqrt{2} \cdot \mathrm{~V}_{\text {ign }}}} \approx 72.5 \mathrm{kHz}
\end{aligned}
$$

Figure 11. Resonance curves


The maximum striking current is equal to:
Equation 34

$$
I_{\text {ballast,ign }}=\left(\frac{2 \cdot V_{\text {out }}}{\pi \cdot Z_{0}} \sqrt{\frac{1+\left(Q \frac{f_{i g n}}{f_{0}}\right)}{Q^{2}\left[1-\left(\frac{f_{i g n}}{f_{0}}\right)^{2}\right]^{2}+\left(\frac{f_{\text {ign }}}{f_{0}}\right)^{2}}}\right)=2.121 \mathrm{Apk}
$$

This current is also the saturation current of the ballast choke ( $I_{\text {sat,ballast }}>2.2 \mathrm{~A}$ ).
Limiting the current to this value, the lamp voltage is limited to $700 \mathrm{Vac}\left(\mathrm{V}_{\mathrm{Cres}, \max }>700\right.$ $\mathrm{Vac})$. The half-bridge current sense resistor is chosen according to:

## Equation 35

$$
R_{\text {hbcs }}=\frac{V_{\text {hbcsh }}}{I_{\text {ballast,ign }}}=\frac{1.6 \mathrm{~V}}{2.121 \mathrm{~A}}=0.7543 \Omega \rightarrow \mathrm{R}_{\text {pfccs }}=0.33 \Omega
$$

The RMS value of one side of the half bridge is equal to:

## Equation 36

$$
I_{\mathrm{nb}, \mathrm{RMS}} \approx \frac{I_{\text {ballast,pk }}}{2}=\frac{1}{2} \cdot \frac{2 \cdot V_{\text {out }}}{\pi \cdot Z_{0}} \sqrt{\frac{1+\left(Q \frac{f_{\text {run }}}{f_{0}}\right)}{Q^{2}\left[1-\left(\frac{f_{\mathrm{run}}}{f_{0}}\right)^{2}\right]^{2}+\left(\frac{f_{\text {run }}}{f_{0}}\right)^{2}}}=0.3465 \mathrm{~A}
$$

The power dissipation of the half-bridge current sense resistor is equal to:

## Equation 37

$$
P_{\mathrm{hbcs}} \approx \mathrm{R}_{\mathrm{hbcs}} \cdot \mathrm{I}_{\mathrm{hbs}, \mathrm{RMs}}^{2}<100 \mathrm{~mW}
$$

A blocking capacitor $\mathrm{C}_{\text {block }}=100 \mathrm{nF}(400 \mathrm{Vac})$ is used.
The choke form factor is an EF25 core $\left(A_{e}=52 \mathrm{~mm}^{2}, \mathrm{I}_{\mathrm{e}}=58 \mathrm{~mm}\right.$, material N87 or equivalent having $\mathrm{B}_{\max }<300 \mathrm{mT}$ ).
Its design parameters are as follows:

## Equation 38

$$
\left.\begin{array}{l}
N=\frac{I_{\max } L}{B_{\max } A_{e}}=183 \text { turns } \\
A_{L}=\frac{L}{N^{2}}=38.8 \mathrm{nH} / \text { turns }^{2}
\end{array}\right\} \rightarrow I_{\text {gap }}=2 \times \frac{\mu_{0} \mathrm{~N}^{2} A_{e}}{\mathrm{~L}}=3.37 \mathrm{~mm}
$$

For this component a multi-conductor wire is also used to reduce the HF equivalent resistance, and therefore the power dissipation.

### 2.2 Selection of parameters

Figure 12. Parameters setting block

$\mathrm{C}_{\text {osc }}=1 \mathrm{nF}$ ( $5 \%$ or better) is chosen.
The following constant values are calculated ( $\mathrm{C}_{\mathrm{Osc}}$ in pF ):

## Equation 39

$$
k=\frac{499.6 \cdot 10^{3}}{\left(C_{\text {OSC }}\right)^{0.872}}=1209.55
$$

## Equation 40

$$
\mathrm{e}=1-\frac{1.33}{\left(\mathrm{C}_{\mathrm{OSC}}\right)^{0.581}}=0.976
$$

Given the run frequency and the preheating frequency (both in kHz ), the following components are found:

## Equation 41

$$
\begin{aligned}
& R_{\text {run }}=\left(\frac{k}{f_{\text {run }}}\right)^{\frac{1}{e}}=26.99 \mathrm{k} \Omega \rightarrow R_{\text {run }}=26.7 \mathrm{k} \Omega \\
& R_{\text {pre }} / / R_{\text {run }}=\left(\frac{k}{f_{\text {pre }}}\right)^{\frac{1}{e}}=12.86 \mathrm{k} \Omega \rightarrow R_{\text {pre }}=\frac{R_{\text {run }} \cdot 12.86 \mathrm{k} \Omega}{R_{\text {run }}-12.86 \mathrm{k} \Omega}=24.9 \mathrm{k} \Omega
\end{aligned}
$$

An ignition time equal to 50 ms is obtained using a $\mathrm{C}_{\mathrm{ign}}$ corresponding to:

## Equation 42

$$
\mathrm{T}_{\mathrm{ign}}=3 \mathrm{R}_{\mathrm{pre}} \mathrm{C}_{\mathrm{ign}} \rightarrow \mathrm{C}_{\mathrm{ign}}=680 \mathrm{nF}
$$

A protection time equal to 120 ms is adopted, then:

## Equation 43

$$
\mathrm{T}_{\text {prot }}=269740 \cdot \mathrm{C}_{\mathrm{d}} \rightarrow \mathrm{C}_{\mathrm{d}}=470 \mathrm{nF}
$$

The preheating time is equal to almost 1 s , therefore:

## Equation 44

$$
\mathrm{T}_{\text {pre }}=4.63 \frac{\mathrm{C}_{\mathrm{d}}}{\mathrm{I}_{\mathrm{TCH}}}+\mathrm{R}_{\mathrm{d}} \mathrm{C}_{\mathrm{d}} \ln \left(\frac{4.63}{1.5}\right) \rightarrow \mathrm{R}_{\mathrm{d}}=1.755 \mathrm{M} \Omega
$$

The closest commercial resistor for $R_{d}$ is $1.5 \mathrm{M} \Omega$. With this value $T_{p r e}$ is equal to 865 ms .

### 2.3 Half-bridge design

The maximum power loss acceptable for half-bridge MOSFETs is equal to 500 mW . Each MOSFET experiences a conduction loss equal to:

## Equation 45

$$
\mathrm{P}_{\mathrm{cond}}=\mathrm{R}_{\mathrm{DS}(\mathrm{on})} \cdot\left(\mathrm{I}_{\mathrm{rms}}\right)^{2}<0.25 \mathrm{~W}
$$

With $I_{r m s}{ }^{2}=0.120 A^{2}$, a maximum $R_{D S(o n)}=2.08 \Omega$ is obtained.

The following ST MOSFETs meet these constraints:

- STD5NK50Z
- STD6NK50Z
- STD7NM50N

The STD7NM50N has $R_{D S(o n)}=1.12 \Omega\left(\right.$ at $\left.100^{\circ} \mathrm{C}\right)$, therefore the power dissipation related to the half-bridge MOSFETs is equal to almost 270 mW .

The size of the boostrap capacitor can be calculated by solving the following equation:

## Equation 46

$$
\mathrm{C}_{\text {gate }}+\mathrm{C}_{\mathrm{boot}, \min }=\frac{\mathrm{C}_{\mathrm{boot}, \min } \cdot \mathrm{~V}_{\mathrm{cc}}}{\mathrm{~V}_{\mathrm{cc}}-\Delta \mathrm{V}}
$$

where:

$$
\begin{aligned}
\Delta \mathrm{V} & =\mathrm{V}_{\mathrm{cc}, \min }-\mathrm{V}_{\mathrm{gate}, \min }=9.6 \mathrm{~V}-8 \mathrm{~V}=1.6 \mathrm{~V} \\
\mathrm{~V}_{\mathrm{cc}} & =15 \mathrm{~V}-\mathrm{V}_{\mathrm{f}}, \mathrm{~V}_{\mathrm{f}}=\text { forward voltage of charge pump diode }=0.8 \mathrm{~V} \\
\mathrm{Q}_{\mathrm{g}} & =\text { total gate charge of STD7NM50N }=12 \mathrm{nC} \\
\mathrm{C}_{\text {gate }} & =\mathrm{Q}_{\mathrm{g}} / \mathrm{V}_{\mathrm{cc}}=845 \mathrm{pF} \\
\mathrm{C}_{\text {boot,min }} & =6.6 \mathrm{nF} \text { is obtained }
\end{aligned}
$$

$A C_{b o o t}=100 \mathrm{nF}$ is selected and the voltage drop is equal to $\Delta \mathrm{V}=120 \mathrm{mV}$.
The charging time of the capacitor is calculated to check if $\Delta \mathrm{V}$ is compensated during the on-time of the low side. The time the capacitor takes to charge to $95 \%$ of $\mathrm{V}_{\mathrm{cc}}$ starting from 0 is equal to:

## Equation 47

$$
\mathrm{t}_{0}=3 \cdot \mathrm{R}_{\text {boot }} \cdot \mathrm{C}_{\text {boot }}=3 \cdot 250 \Omega \cdot 100 \mathrm{nF}=75 \mu \mathrm{~s}
$$

The time the capacitor takes to charge to $95 \%$ of $V_{c c}$ minus 120 mV starting from 0 is equal to:

## Equation 48

$$
t_{1}=-R_{b o o t} \cdot C_{b o o t} \cdot \ln \left(1-\frac{0.95 \cdot V_{c c}-0.12}{V_{c c}}\right)=2.839 \cdot R_{b o o t} \cdot C_{b o o t}=71 \mu \mathrm{~s}
$$

The difference $t_{0}-t_{1}=4 \mu$ s is smaller than the minimum on-time equal to:

## Equation 49

$$
\mathrm{T}_{\mathrm{on}, \min }=\frac{1}{2 \mathrm{f}_{\mathrm{pre}}}-\mathrm{T}_{\mathrm{DEAD}, \max }=4.11 \mu \mathrm{~s}
$$

The selected capacitor is able to correctly supply the high-side driver.

### 2.4 End of life detection

In this design the blocking capacitor to ground configuration is chosen.
Figure 13. Blocking capacitor to ground topology


The tracking configuration with a window of amplitude equal to 240 mV is selected, connecting EOLP to ground with $\mathrm{R}_{\text {EOLP }}=240 \mathrm{k} \Omega$.
The EOL pin detects the blocking capacitor voltage by means of a voltage divider that, in normal conditions, sets its voltage to the same value as the CTR pin:

## Equation 50

$$
\mathrm{V}_{\mathrm{CTR}, 0}=\mathrm{V}_{\text {out }} \frac{\mathrm{R}_{\mathrm{ctrl}}}{\mathrm{R}_{\mathrm{ctrl}}+\mathrm{R}_{\mathrm{ctrh}}}=3.03 \mathrm{~V} \leftarrow \mathrm{~V}_{\mathrm{EOL}}
$$

Choosing the total upper resistor value equal to $R_{e o l 1}=1.36 \mathrm{M} \Omega(2 \times 680 \mathrm{k} \Omega)$, and with the steady-state value of the blocking capacitor voltage equal to $\mathrm{V}_{\text {out }} / 2$, the lower resistor is calculated as:

## Equation 51

$$
\mathrm{R}_{\mathrm{eol} 2}=\mathrm{R}_{\mathrm{eol1}} \frac{2 \mathrm{~V}_{\mathrm{EOL}}}{\mathrm{~V}_{\mathrm{OUT}}-2 \mathrm{~V}_{\mathrm{EOL}}}=19.9 \mathrm{k} \Omega \rightarrow \mathrm{R}_{\mathrm{eol} 2}=20 \mathrm{k} \Omega
$$

$A C_{e o l}=10 \mathrm{nF}$ capacitor is used to filter the lamp frequency, maintaining the ripple. The obtained cutoff frequency is calculated higher than 100 Hz , but lower than 49 kHz .

Equation 52

$$
\mathrm{f}_{\mathrm{c}, \mathrm{eol}} \approx \frac{1}{2 \pi \cdot \mathrm{R}_{\mathrm{eol} 2} \cdot \mathrm{C}_{\mathrm{eol}}}=796 \mathrm{~Hz}
$$

### 2.5 IC power supply design

The IC current consumption depends on both the PFC frequency and half-bridge frequency. In the worst case, the mean value of the PFC frequency is equal to 162 kHz and the maximum half-bridge frequency is equal to 90 kHz .

With these values the maximum supply current is approximately equal to:

## Equation 53

$$
\mathrm{I}_{\mathrm{cc}_{\mathrm{mA}}}=0.0192 \cdot\left\langle\mathrm{f}_{\mathrm{PFC}}\right\rangle_{\mathrm{kHz}}+0.0373 \mathrm{f}_{\mathrm{pre}_{\mathrm{kHz}}}+4.56 \approx 11 \mathrm{~mA}
$$

This current is delivered to the IC by means of a charge pump connected to the middle point of the half bridge.

Figure 14. Charge pump network and startup


The current delivered by the charge pump capacitor is approximately:

## Equation 54

$$
I_{\mathrm{cp}}=I_{\mathrm{cp}, \mathrm{pk}} \cdot T_{\text {rise }} \cdot f_{\mathrm{run}} \geq I_{\mathrm{cc}}
$$

where:

## Equation 55

$$
I_{\mathrm{cp}, \mathrm{pk}}=C_{\mathrm{cp}} \frac{V_{\text {out }}}{T_{\text {rise }}}
$$

and rearranging the terms:

## Equation 56

$$
\mathrm{C}_{\mathrm{cp}} \geq \frac{\mathrm{I}_{\mathrm{cp}}}{\mathrm{~V}_{\mathrm{OUT}} \cdot \mathrm{f}_{\mathrm{run}}}=558 \mathrm{pF} \rightarrow \mathrm{C}_{\mathrm{cp}}=1 \mathrm{nF}
$$

The startup network works also as a detector of lamp presence. This feature can be implemented by placing one or both of the lamp cathodes along the startup network path. If the lamp is absent, the IC cannot start.

The minimum startup current of the L6585DE is equal to $\mathrm{I}_{\mathrm{cc}, \text { on }}=370 \mu \mathrm{~A}$. This current has to be delivered to the IC at the minimum input voltage ( 125 Vpk ), therefore a total resistance equal to:

## Equation 57

$$
\mathrm{R}_{\text {su,tot }}=\frac{\mathrm{V}_{\mathrm{in}, \min }}{\mathrm{I}_{\mathrm{cc}, \mathrm{on}}}=337 \mathrm{k} \Omega
$$

The network is divided into $5 \times 68 \mathrm{k} \Omega$ resistors in order to avoid damage due to the lamp striking voltage.

A C1 $=10 \mu \mathrm{~F}$ followed by a 100 nF ceramic capacitor is used as the $\mathrm{V}_{\mathrm{cc}}$ bulk capacitor.

## 3 Demonstration board schematic and bill of material

Figure 15. STEVAL-ILB005V2 schematic


AM04243v1

Table 2. BOM

| Reference | Value | Note |
| :---: | :---: | :---: |
| R1 | $681 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {mult,hi }}$ |
| R2 | $681 \mathrm{k} \Omega$ |  |
| R3 | $681 \mathrm{k} \Omega$ |  |
| R4 | $16.2 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {mult,lo }}$ |
| R5 | 2.2 M $\Omega$ | $\mathrm{R}_{\text {inv, } \mathrm{hi}}$ |
| R6 | 2.2 M $\Omega$ |  |
| R7 | $2.2 \mathrm{M} \Omega$ |  |
| R8 | $39.2 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {inv, }}$ lo |
| R9 | n.m. |  |
| R10 | $75 \mathrm{k} \Omega$ | $\mathrm{R}_{\mathrm{zcd}}$ |
| R11 | $47 \Omega$ | PFC MOSFET gate resistor |
| R12 | $220 \Omega$ | PFC current sense filtering resistor |
| R13 | $825 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {ctr,hi }}$ |
| R14 | $825 \mathrm{k} \Omega$ |  |
| R15 | $825 \mathrm{k} \Omega$ |  |
| R16 | $18 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {ctr,lo }}$ |
| R18 | $26.1 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {run }}$ |
| R19 | $29.4 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {pre }}$ |
| R20 | $1.5 \mathrm{M} \Omega$ | $\mathrm{R}_{\mathrm{D}}$ |
| R21 | ORO |  |
| R22 | $240 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {eolp }}$ |
| R23 | ORO |  |
| R24 | $47 \Omega$ | High-side MOSFET gate resistor |
| R25 | $47 \Omega$ | Low-side MOSFET gate resistor |
| R26 | $3.3 \Omega$ | Charge pump limiting resistor |
| R27 | $3.3 \Omega$ |  |
| R28 | $68 \mathrm{k} \Omega$ | Startup network |
| R29 | $68 \mathrm{k} \Omega$ |  |
| R30 | $560 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {EOL, hi }}(1)$ |
| R31 | $120 \mathrm{k} \Omega$ |  |
| R32 | $20.5 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {EOL,Io }}$ |
| R33 | $68 \mathrm{k} \Omega$ | Startup network |
| R34 | $68 \mathrm{k} \Omega$ |  |
| R35 | $68 \mathrm{k} \Omega$ |  |

Table 2. BOM (continued)

| Reference | Value | Note |
| :---: | :---: | :---: |
| R40 | $680 \mathrm{k} \Omega$ | $\mathrm{R}_{\text {EOL, hi }}(2)$ |
| R41 | n.m. |  |
| RS1 | $0.33 \Omega-0.5 \mathrm{~W}$ | $\mathrm{R}_{\text {pfccs }}$ |
| RS2 | $0.82 \Omega-0.5 \mathrm{~W}$ | $\mathrm{R}_{\text {hbcs }}$ |
| C1 | $22 \mu \mathrm{~F}-450 \mathrm{~V}$ | $\mathrm{C}_{\text {OUT }}$ |
| CA1 | ORO |  |
| C2 | 470 nF - 305 Vac | $\mathrm{C}_{\text {in }}$ |
| C3 | 4.7 nF | MULT filtering capacitor |
| C4 | 1 nF | PFCCS filtering capacitor |
| C5 | $1 \mu \mathrm{~F}$ | $\mathrm{C}_{\text {comp }}$ |
| C6 | n.m. |  |
| C7 | 10 nF | CTR filtering capacitor |
| C8 | $1 \mathrm{nF}-1 \%$ | $\mathrm{C}_{\text {osc }}$ |
| C9 | $1 \mu \mathrm{~F}$ | $\mathrm{C}_{\text {ign }}$ |
| C10 | 470 nF | $\mathrm{C}_{\mathrm{d}}$ |
| C11 | 100 nF | $\mathrm{C}_{\text {boot }}$ |
| C12 | $1 \mathrm{nF}-630 \mathrm{Vdc}$ | $\mathrm{C}_{\mathrm{cp}}$ |
| C13 | $10 \mu \mathrm{~F}$ | $\mathrm{C}_{\mathrm{Vcc}}$ |
| C14 | 100 nF | $\mathrm{C}_{\mathrm{Vcc}, \mathrm{b}}$ |
| C15 | 4.7 nF-2 kV | $\mathrm{C}_{\text {res }}$ |
| C16 | 100 nF -630Vdc | $\mathrm{C}_{\text {block }}$ |
| C17 | 10 nF | EOL filtering capacitor |
| C18 | 1 nF |  |
| C20 | $100 \mathrm{nF}, \mathrm{X} 2,275 \mathrm{Vac}$ | Differential mode EMI filter |
| C21 | $100 \mathrm{nF}, \mathrm{X} 2,275 \mathrm{Vac}$ | Differential mode EMI filter |
| C22 | $1 \mathrm{nF} \mathrm{Y1}$ | Common mode EMI filter (capacitive) |
| C23 | $1 \mathrm{nF} \mathrm{Y1}$ | Common mode EMI filter (capacitive) |
| C24 | 0R0 |  |
| D1 | STTH1L06 | Boost diode |
| D2 | 1N4148 | Charge pump forward diode |
| D3 | 1N4148 | PFC gate speed-up diode |
| DZ1 | BZX84C15 | Charge pump free-wheeling Zener diode |
| DZ2 | 0R0 |  |
| DZ3 | 0R0 |  |
| DZ4 | n.m. |  |

Table 2. BOM (continued)

| Reference | Value | Note |
| :---: | :---: | :---: |
| B1 | 2KBP06M | Rectifier bridge |
| U1 | L6585DE | Ballast controller |
| Q1 | STD7NM50N | PFC MOSFET |
| Q2 | STD7NM50N | Half-bridge high-side MOSFET |
| Q3 | STD7NM50N | Half-bridge low-side MOSFET |
| T1 | $1.5 \mathrm{mH}-2.6 \mathrm{~A}$ | PFC transformer - EPCOS B78313P8140 |
| T2 | $2 \times 68 \mathrm{mH}-0.9 \mathrm{~A}$ | Common mode EMI filter - EPCOS B82733F2901 |
| L1 | $1.3 \mathrm{mH}-2.6 \mathrm{~A}$ | Ballast choke - ITACOIL E2543-H |
| F1 | T2 A -250 Vac | Fuse |
| RT1 | NTC $5 \Omega$ | Inrush current limiter |

### 3.1 Demonstration board performances

Figure 16. Input performance - power factor
Figure 17. Input performance - total harmonic distortion


Figure 18. EMI spectrum at 277 Vac


Figure 19. EMI spectrum at 88 Vac

AM04246v1



AM04247v1

### 3.2 Ballast stage performance and reliability

Figure 20 shows the lamp parameters. Small discrepancies between theoretical and real measurements are due to the tolerance of the passive components of the resonance network ( $\mathrm{L}_{\text {res }}$ and $\mathrm{C}_{\text {res }}$ ).

Figure 20. Steady-state lamp parameters


AM04248v1
Figure 21 summarizes the $T_{c h}$ sequences during preheating and protections. During the open lamp test, $\mathrm{T}_{\text {ch }}$ voltage (lower trace) sets the preheating time ( $\mathrm{T}_{\text {pre }}=805 \mathrm{~ms}$ ). After that the lamp voltage (upper trace) increases up to the maximum value allowed by the HBCS resistor ( 740 Vrms ). The subsequent protection time is shorter than the preheating time ( 120 ms ).

Figure 21. Startup sequence with open lamp protection


In Figure 22 a close-up of the waveforms during a ballast choke saturation is shown. The upper graph illustrates the lamp parameters. While the lamp voltage remains essentially sinusoidal, the lamp current becomes triangular cycle by cycle. The lower trace illustrates the half-bridge current sense voltage $\left(\mathrm{V}_{\mathrm{HBCS}}\right)$. As soon as this voltage reaches 2.75 V , the application is immediately stopped.

The saturation effect does not have a definite threshold. Once the current is close to saturation, the inductance value starts to decrease slowly and constantly, therefore a current
limiting that maintains the frequency constant is not suitable to counter this effect. Actually the application should be stopped as soon as the saturation effect is detected.

Figure 22. Ballast anti-choke saturation protection


Asymmetrical ageing of the lamp is detected by the EOL pin. Figure 23 and 24 illustrate the behavior of this protection. In the upper trace the lamp voltage and $T_{c h}$ voltage are shown. When the lamp starts ageing, the lamp voltage increases in one direction. The EOL voltage (lower trace) moves together with the blocking capacitor voltage. Once the difference between the CTR voltage and the EOL voltage is higher than 240 mV , a $\mathrm{T}_{\text {ch }}$ cycle is started and the application is stopped if this situation persists.

Figure 23. EOL protection (positive deviation)


Figure 24. EOL protection (negative deviation)


## 4 Revision history

Table 3. Document revision history

| Date | Revision | Changes |
| :---: | :---: | :--- |
| 15-Mar-2010 | 1 | Initial release. |

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